

**Notice of References Cited**

Application/Control No.

09/583,617

Applicant(s)/Patent Under  
Reexamination  
GORUGANTHU ET AL.

Examiner

Bernard E Souw

Art Unit

2881

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Oki Technical Review, at " <a href="http://www.oki.com/en/otr/html/nf/otr-185-14-fig-1.html">http://www.oki.com/en/otr/html/nf/otr-185-14-fig-1.html</a> ".
	V	Belleville et al., "Low Power SOI Design", <a href="http://patmos2001.eivd.ch/program/Repro%5CART_8_1.pdf">http://patmos2001.eivd.ch/program/Repro%5CART_8_1.pdf</a>
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